

650V N-ch Planar MOSFET

General Features

- RoHS Compliant
- ightharpoonup R_{DS(ON),typ.}=1.9 Ω @V_{GS}=10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

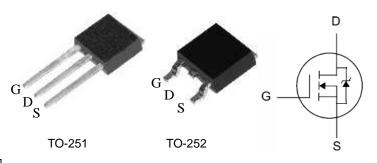
- Adaptor
- Charger
- SMPS Standby Power

Ordering Information

| Part Number | Package | Brand |
|-------------|---------|-------|
| PSU04N65B | TO-251 | ĭ |
| PSD04N65B | TO-252 | ĭ |

Lead Free Package and Finish

| BV _{DSS} | R _{DS(ON),typ.} | I _D |
|-------------------|--------------------------|----------------|
| 650V | 1.9Ω | 4.0A |



Package No to Scale

Absolute Maximum Ratings

T_C=25°C unless otherwise specified

| Symbol | Parameter | PSU04N65B | PSD04N65B | Unit | |
|-----------------------------------|--|------------|-----------|------|--|
| V_{DSS} | Drain-to-Source Voltage | 650 | | V | |
| V_{GSS} | Gate-to-Source Voltage | ± | ±30 | | |
| I _D | Continuous Drain Current | 4 | 4.0 | | |
| I _{DM} | Pulsed Drain Current at V _{GS} =10V | 16 | | А | |
| E _{AS} | Single Pulse Avalanche Energy | 250 | | mJ | |
| D | Power Dissipation | 86 | | W | |
| r _D | P _D Derating Factor above 25 ℃ | | 0.68 | | |
| T _L | Soldering Temperature Distance of 1.6mm from case for 10 seconds | 300 | | °C | |
| T _J & T _{STG} | Operating and Storage Temperature Range | -55 to 150 | | C | |

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

| Symbol | Parameter | PSU04N65B PSD04N65B | | PSU04N65B PSD04N65B | | Unit |
|----------------|---|---------------------|-------|---------------------|--|------|
| $R_{	heta JC}$ | Thermal Resistance, Junction-to-Case | 1.4 | 40.44 | | | |
| $R_{	hetaJA}$ | Thermal Resistance, Junction-to-Ambient | 75 | | °CM | | |



Electrical Characteristics

OFF Characteristics

T_J =25°C unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Unit | Test Conditions |
|---|--|------|------|------|--|--|
| BV_{DSS} | Drain-to-Source Breakdown Voltage | 650 | | | V | V _{GS} =0V, I _D =250uA |
| Durinta Committee Commit | | | 1 | | V _{DS} =650V, V _{GS} =0V | |
| IDSS | I _{DSS} Drain-to-Source Leakage Current | | | 100 | uA | V _{DS} =520V, V _{GS} =0V, T _J =125°C |
| | Cata to Source Leakage Current | | | +10 | | V _{GS} =+20V, V _{DS} =0V |
| I _{GSS} Gate-to-Source Leakage Current | | | -10 | uA | V _{GS} =-20V, V _{DS} =0V | |

ON Characteristics

T_J =25°C unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Unit | Test Conditions |
|---------------------|---|------|------|------|------|--|
| R _{DS(ON)} | Static Drain-to-Source On-Resistance | | 1.9 | 2.5 | Ω | V _{GS} =10V, I _D =2.0A |
| $V_{\text{GS(TH)}}$ | Gate Threshold Voltage | 2.0 | | 4.0 | V | $V_{DS}=V_{GS}$, $I_{D}=250uA$ |
| gfs | Forward Transconductance | | 5.0 | | S | V _{DS} =15V,ID=2.0A |

Dynamic Characteristics

Essentially independent of operating temperature

| <i>y</i> | | Localitiany independent of operating temperature | | | | |
|------------------|-------------------------------|--|------|------|------|--|
| Symbol | Parameter | Min. | Тур. | Max. | Unit | Test Conditions |
| C _{iss} | Input Capacitance | | 450 | | | V 0V |
| C _{rss} | Reverse Transfer Capacitance | | 6.0 | | pF | V_{GS} =0V, V_{DS} =25V, f =1.0MH $_{Z}$ |
| C _{oss} | Output Capacitance | | 50 | | | |
| Qg | Total Gate Charge | | 8.5 | | | |
| Q _{gs} | Gate-to-Source Charge | | 2.8 | | nC | V_{DD} =325V, I_{D} =4A, V_{GS} =0 to 10V |
| Q_{gd} | Gate-to-Drain (Miller) Charge | | 2.5 | |] | |
| | | | | | | |

Resistive Switching Characteristics Es

Essentially independent of operating temperature

| Symbol | Parameter | Min. | Тур. | Max. | Unit | Test Conditions |
|---------------|---------------------|------|------|------|------|---------------------------------|
| td(ON) | Turn-on Delay Time | | 9.0 | | | |
| trise | Rise Time | | 7.0 | | | V_{DD} =325V, I_{D} =4A, |
| td(OFF) | Turn-Off Delay Time | | 22 | | nS | $V_{GS}=10V$ Rg=4.7 Ω |
| t fall | Fall Time | | 9.0 | | | 3 |



Source-Drain Body Diode Characteristics T_J=25℃ unless otherwise specified

| Symbol | Parameter | Min | Тур. | Max. | Unit | Test Conditions |
|-----------------|--|-----|------|------|------|---|
| I _{SD} | Continuous Source Current ^[2] | | | 4.0 | ۸ | Integral pn-diode |
| I _{SM} | Pulsed Source Current ^[2] | | | 16 | Α | in MOSFET |
| V _{SD} | Diode Forward Voltage | | | 1.5 | V | I _S =4A, V _{GS} =0V |
| trr | Reverse Recovery Time | | 235 | | ns | Vgs=0V |
| Qrr | Reverse Recovery Charge | | 750 | | nC | IF= I _S , di/dt=100A/µs |

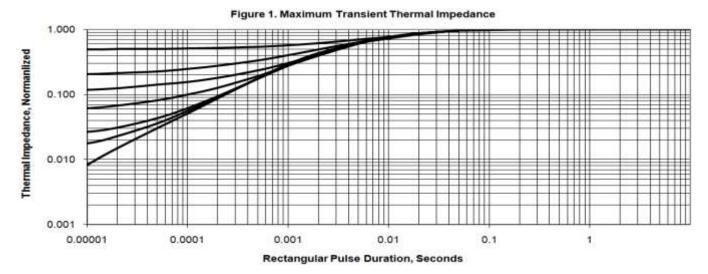
Note:

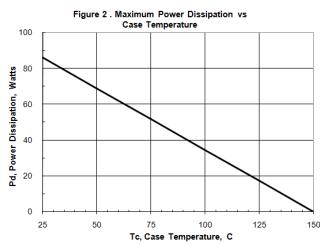
^[1] T_J=+25℃ to +150℃

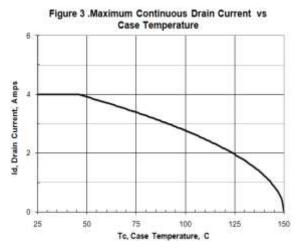
^[2] Pulse width≤380µs; duty cycle≤2%.

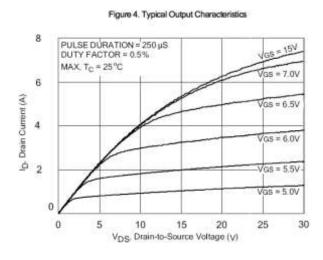


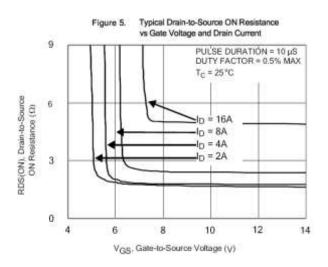
Typical Characteristics







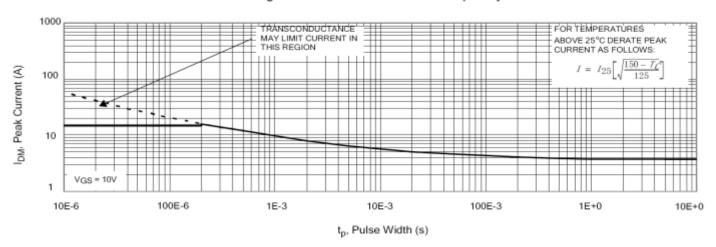






Typical Characteristics(Cont.)

Figure 6. Maximum Peak Current Capability



AS, Avalanche Current (A)

Figure 7. Typical Transfer Characteristics

PULSE DURATION = 10 µs
DUTY CYCLE = 0.5% MAX
VDS = 30V

*150°C
+25°C
-55°C

VGS, Gate-to-Source Voltage (V)

Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

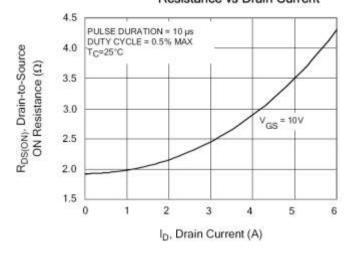


Figure 8. Unclamped Inductive Switching Capability

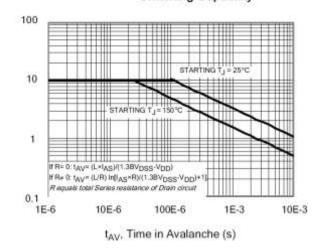
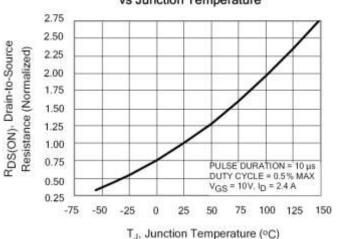


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature





Typical Characteristics(Cont.)

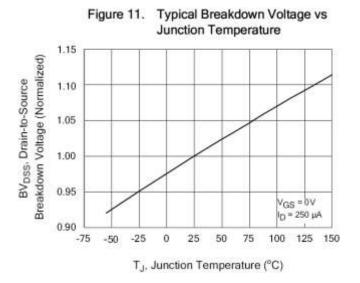


Figure 13 . Maximum Safe Operating Area

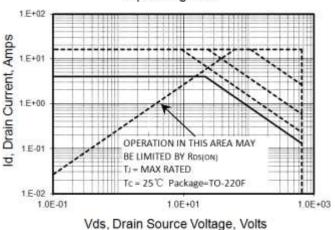


Figure 15 . Typical Gate Charge

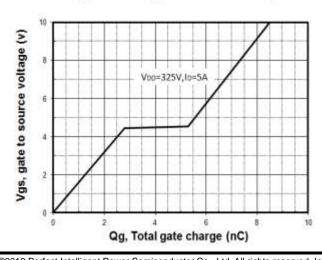


Figure 12. Typical Threshold Voltage vs Junction Temperature

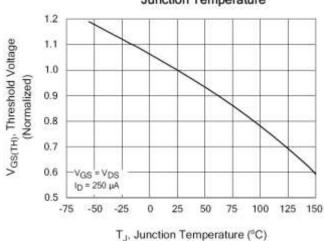
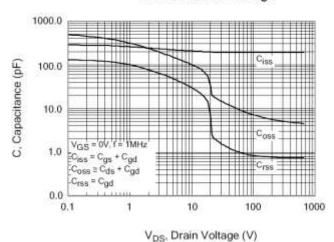


Figure 14. Typical Capacitance vs Drain-to-Source Voltage



12 ISD, Reverse Drain Current (A) 10 8 6 +25 °C 4 2 $V_{GS} = 0V$ 0.2 0.4 0.6 8.0 1.0 1.2 1.4 V_{SD}, Source-to-Drain Voltage (V)

Figure 16. Typical Body Diode Transfer Characteristics



Test Circuits and Waveforms

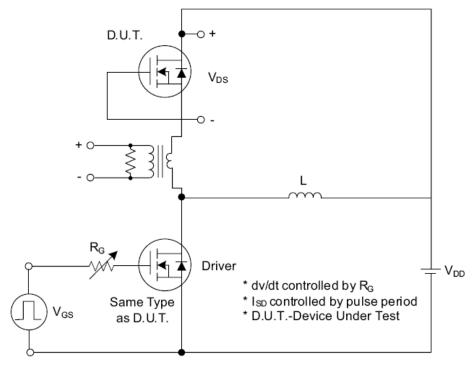


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

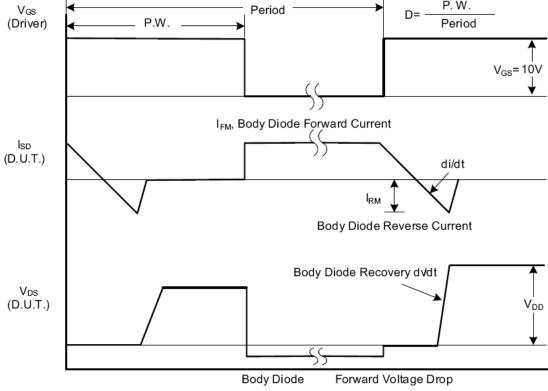


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms



Test Circuits and Waveforms (Cont.)

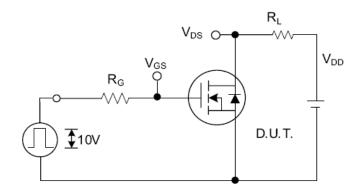


Fig. 2.1 Switching Test Circuit

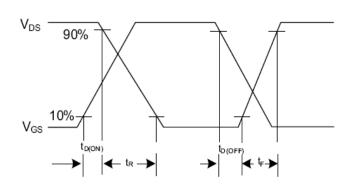


Fig. 2.2 Switching Waveforms

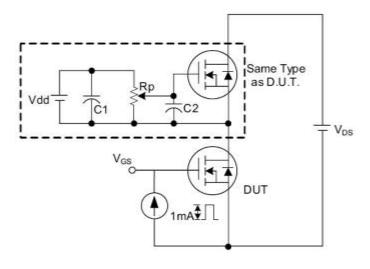


Fig. 3 . 1 Gate Charge Test Circuit

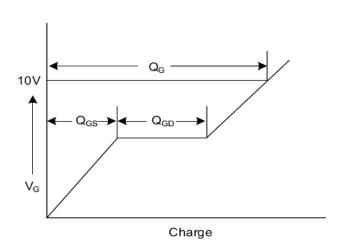


Fig. 3.2 Gate Charge Waveform

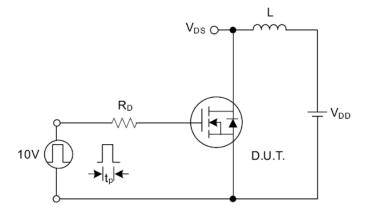


Fig. 4.1 Unclamped Inductive Switching Test Circuit

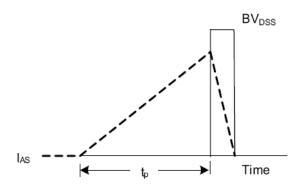


Fig. 4.2 Unclamped Inductive Switching Waveforms



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